

# PHP/PHB45NQ15T

N-channel TrenchMOS™ standard level FET

Rev. 01 — 8 November 2004

Product data sheet

## 1. Product profile

### 1.1 General description

Standard level N-channel enhancement mode field effect transistor in a plastic package using TrenchMOS™ technology.

### 1.2 Features

- Low on-state resistance
- Low thermal resistance
- Fast switching
- Low gate charge.

### 1.3 Applications

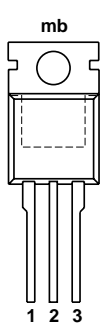
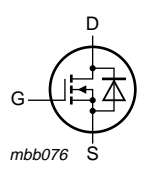
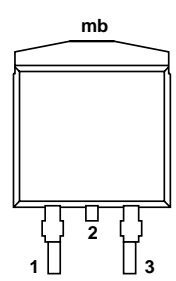
- DC-to-DC primary side switching
- AC-to-DC secondary side rectification.

### 1.4 Quick reference data

- $V_{DS} \leq 150$  V
- $R_{DS(on)} \leq 42$  m $\Omega$
- $I_D \leq 45.1$  A
- $Q_{gd} = 10.3$  nC (typ).

## 2. Pinning information

Table 1: Discrete pinning

Pin	Description	Simplified outline	Symbol
1	gate		
2	drain <sup>[1]</sup>		
3	source		
mb	mounting base; connected to drain		<i>mbb076</i>
		SOT78 (TO-220AB)	SOT404 (D <sup>2</sup> -PAK)

[1] It is not possible to make a connection to pin 2 of the SOT404 package.

### 3. Ordering information

**Table 2: Ordering information**

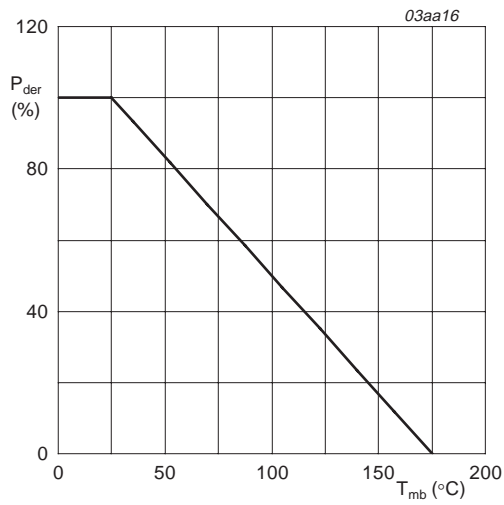
Type number	Package		Version
	Name	Description	
PHP45NQ15T	TO-220AB	Plastic single-ended package; heatsink mounted; 1 mounting hole; 3 lead TO-220AB	SOT78
PHB45NQ15T	D <sup>2</sup> -PAK	Plastic single-ended surface mounted package (D <sup>2</sup> -PAK); 3 leads (one lead cropped)	SOT404

### 4. Limiting values

**Table 3: Limiting values**

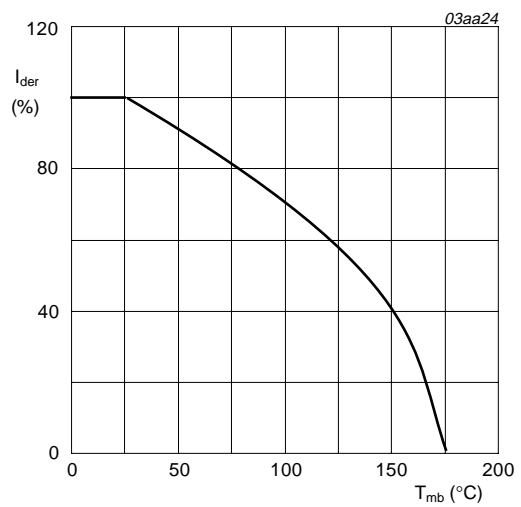
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DS</sub>	drain-source voltage (DC)	25 °C ≤ T <sub>j</sub> ≤ 175 °C	-	150	V
V <sub>DGR</sub>	drain-gate voltage (DC)	25 °C ≤ T <sub>j</sub> ≤ 175 °C; R <sub>GS</sub> = 20 kΩ	-	150	V
V <sub>GS</sub>	gate-source voltage (DC)		-	±20	V
I <sub>D</sub>	drain current (DC)	T <sub>mb</sub> = 25 °C; V <sub>GS</sub> = 10 V; <a href="#">Figure 2</a> and <a href="#">3</a>	-	45.1	A
		T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 10 V; <a href="#">Figure 2</a>	-	31.9	A
I <sub>DM</sub>	peak drain current	T <sub>mb</sub> = 25 °C; pulsed; t <sub>p</sub> ≤ 10 μs; <a href="#">Figure 3</a>	-	90.2	A
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <a href="#">Figure 1</a>	-	230	W
T <sub>stg</sub>	storage temperature		-55	+175	°C
T <sub>j</sub>	junction temperature		-55	+175	°C
<b>Source-drain diode</b>					
I <sub>S</sub>	source (diode forward) current (DC)	T <sub>mb</sub> = 25 °C	-	45.1	A
I <sub>SM</sub>	peak source (diode forward) current	T <sub>mb</sub> = 25 °C; pulsed; t <sub>p</sub> ≤ 10 μs	-	90.2	A
<b>Avalanche ruggedness</b>					
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	unclamped inductive load; I <sub>D</sub> = 19.1 A; t <sub>p</sub> = 0.1 ms; V <sub>DD</sub> ≤ 150 V; R <sub>GS</sub> = 50 Ω; V <sub>GS</sub> = 10 V; starting at T <sub>j</sub> = 25 °C	-	180	mJ



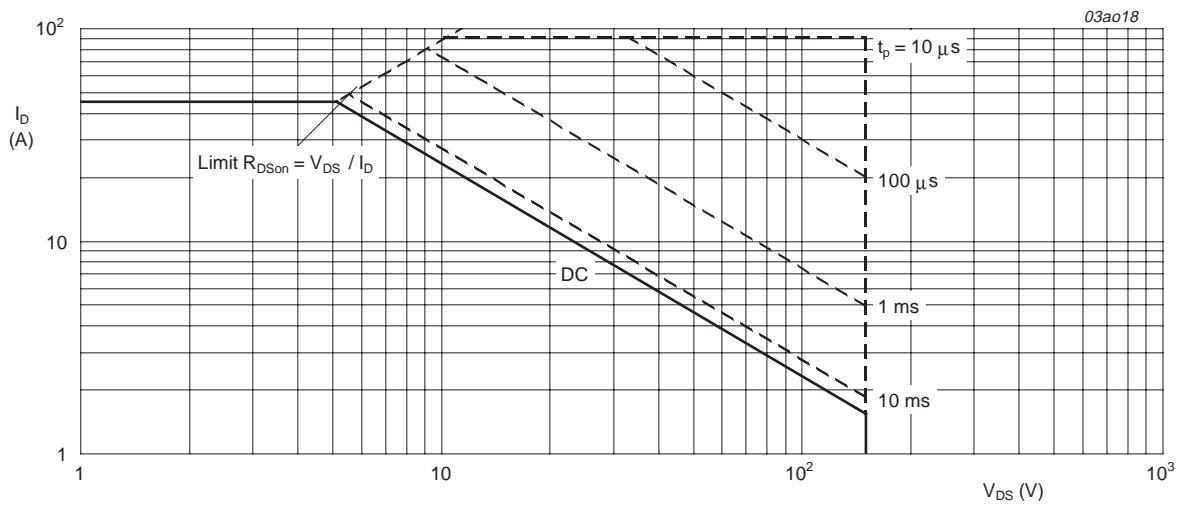
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 1. Normalized total power dissipation as a function of mounting base temperature.



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature.



$T_{mb} = 25^{\circ}C$ ;  $I_{DM}$  is single pulse;  $V_{GS} = 10 V$

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

## 5. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	<a href="#">Figure 4</a>	-	-	0.65	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient					
	SOT78	vertical in free air	-	60	-	K/W
	SOT404	mounted on a printed-circuit board; minimum footprint; vertical in still air	-	50	-	K/W

### 5.1 Transient thermal impedance

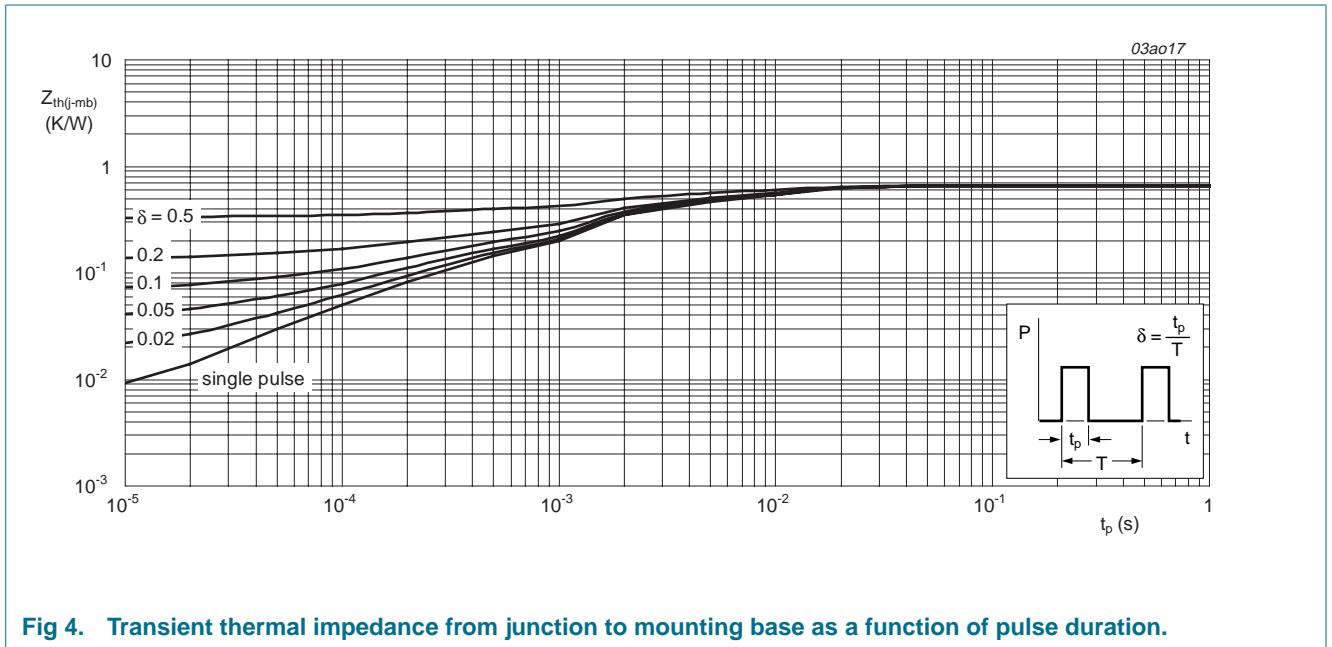
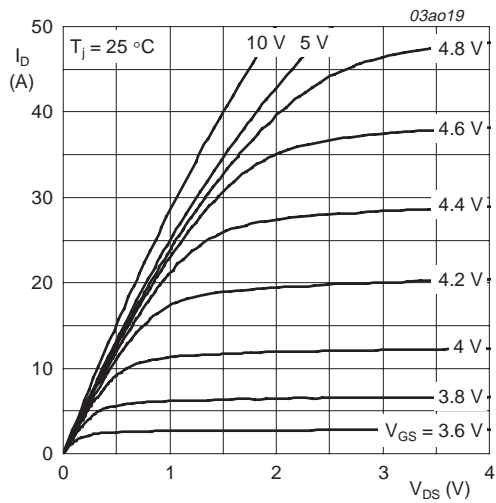


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration.

## 6. Characteristics

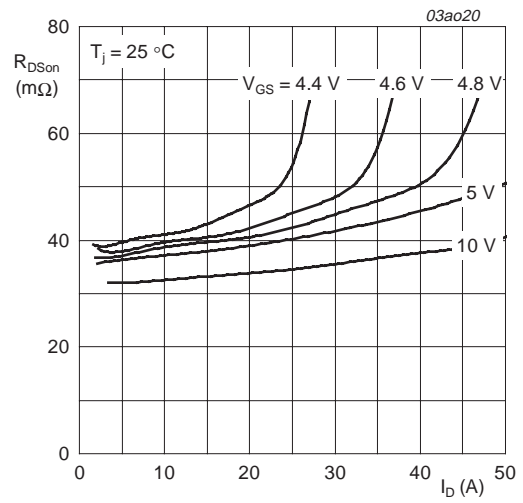
**Table 5: Characteristics**
*T<sub>j</sub> = 25 °C unless otherwise specified.*

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static characteristics</b>						
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	I <sub>D</sub> = 250 μA; V <sub>GS</sub> = 0 V T <sub>j</sub> = 25 °C T <sub>j</sub> = -55 °C	150 135	- -	- -	V V
V <sub>GS(th)</sub>	gate-source threshold voltage	I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; <a href="#">Figure 9</a> and <a href="#">10</a> T <sub>j</sub> = 25 °C T <sub>j</sub> = 175 °C T <sub>j</sub> = -55 °C	2 1 -	3 - -	4 - 4.4	V V V
I <sub>DSS</sub>	drain-source leakage current	V <sub>DS</sub> = 120 V; V <sub>GS</sub> = 0 V T <sub>j</sub> = 25 °C T <sub>j</sub> = 175 °C	- - -	- - -	1 100	μA μA
I <sub>GSS</sub>	gate-source leakage current	V <sub>GS</sub> = ±20 V; V <sub>DS</sub> = 0 V	-	10	100	nA
R <sub>DS(on)</sub>	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 20 A; <a href="#">Figure 6</a> and <a href="#">8</a> T <sub>j</sub> = 25 °C T <sub>j</sub> = 175 °C	- - -	34 91.8	42 113.4	mΩ mΩ
<b>Dynamic characteristics</b>						
Q <sub>g(tot)</sub>	total gate charge	I <sub>D</sub> = 25 A; V <sub>DS</sub> = 75 V; V <sub>GS</sub> = 10 V; <a href="#">Figure 11</a>	-	32	-	nC
Q <sub>gs</sub>	gate-source charge		-	5.6	-	nC
Q <sub>gd</sub>	gate-drain (Miller) charge		-	10.3	-	nC
C <sub>iss</sub>	input capacitance	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; f = 1 MHz; <a href="#">Figure 13</a>	-	1770	-	pF
C <sub>oss</sub>	output capacitance		-	290	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	90	-	pF
t <sub>d(on)</sub>	turn-on delay time	V <sub>DS</sub> = 75 V; R <sub>L</sub> = 3 Ω; V <sub>GS</sub> = 10 V; R <sub>G</sub> = 5.6 Ω	-	11.5	-	ns
t <sub>r</sub>	rise time		-	22	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	42	-	ns
t <sub>f</sub>	fall time		-	31	-	ns
<b>Source-drain diode</b>						
V <sub>SD</sub>	source-drain (diode forward) voltage	I <sub>S</sub> = 25 A; V <sub>GS</sub> = 0 V; <a href="#">Figure 12</a>	-	0.88	1.2	V
t <sub>rr</sub>	reverse recovery time	I <sub>S</sub> = 20 A; di <sub>S</sub> /dt = -100 A/μs; V <sub>GS</sub> = 0 V	-	115	-	ns
Q <sub>r</sub>	recovered charge		-	360	-	nC



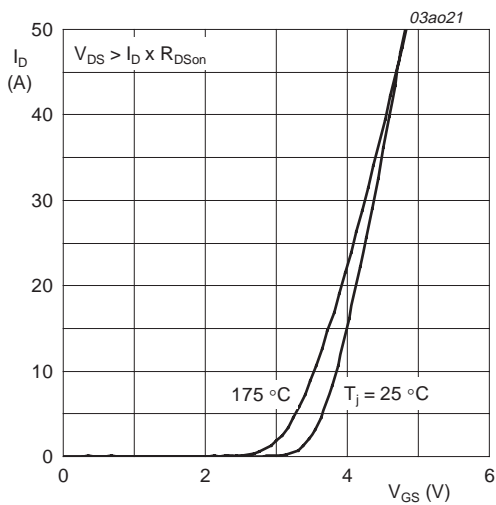
$T_j = 25\text{ °C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



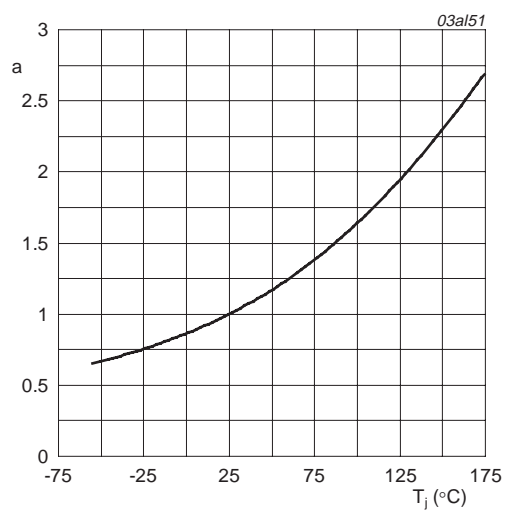
$T_j = 25\text{ °C}$

Fig 6. Drain-source on-state resistance as a function of drain current; typical values.



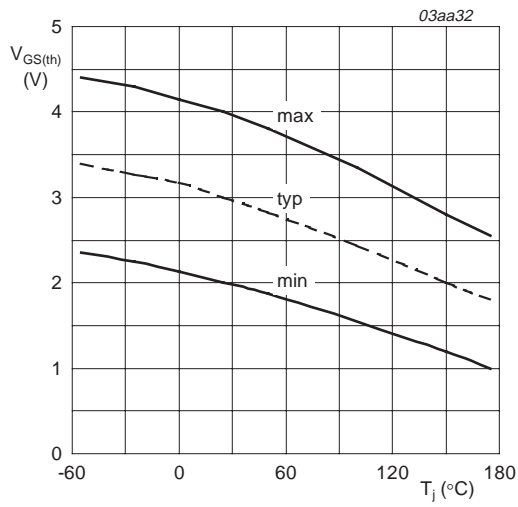
$T_j = 25\text{ °C and }175\text{ °C}; V_{DS} > I_D \times R_{DSon}$

Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



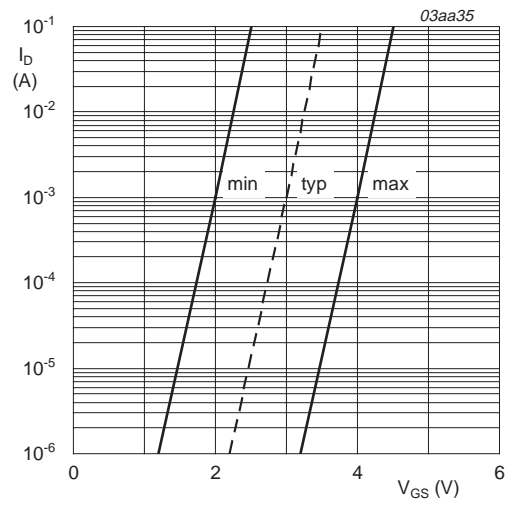
$$a = \frac{R_{DSon}}{R_{DSon(25\text{ °C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



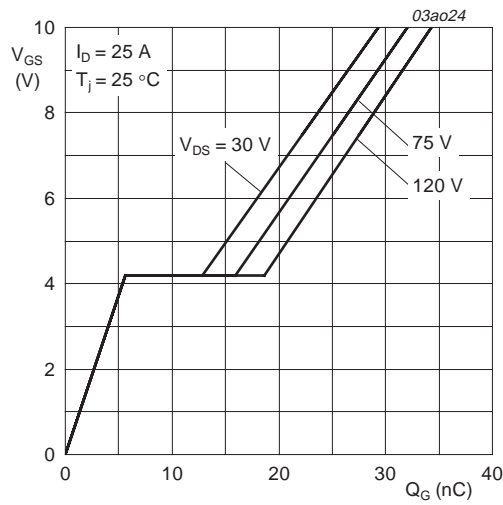
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature.



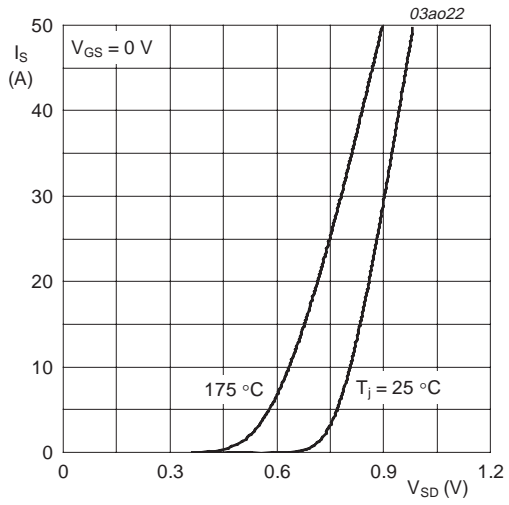
$T_j = 25 \text{ °C}; V_{DS} = 5 \text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



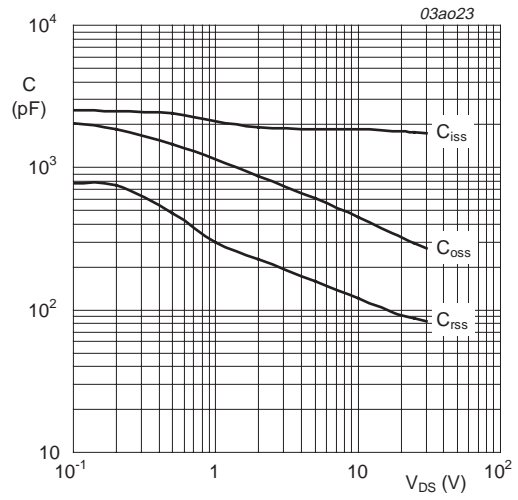
$I_D = 25 \text{ A}; V_{DS} = 30 \text{ V}, 75 \text{ V and } 120 \text{ V}$

Fig 11. Gate-source voltage as a function of gate charge; typical values.



$T_j = 25\text{ °C}$  and  $175\text{ °C}$ ;  $V_{GS} = 0\text{ V}$

**Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.**



$V_{GS} = 0\text{ V}$ ;  $f = 1\text{ MHz}$

**Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.**

7. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78

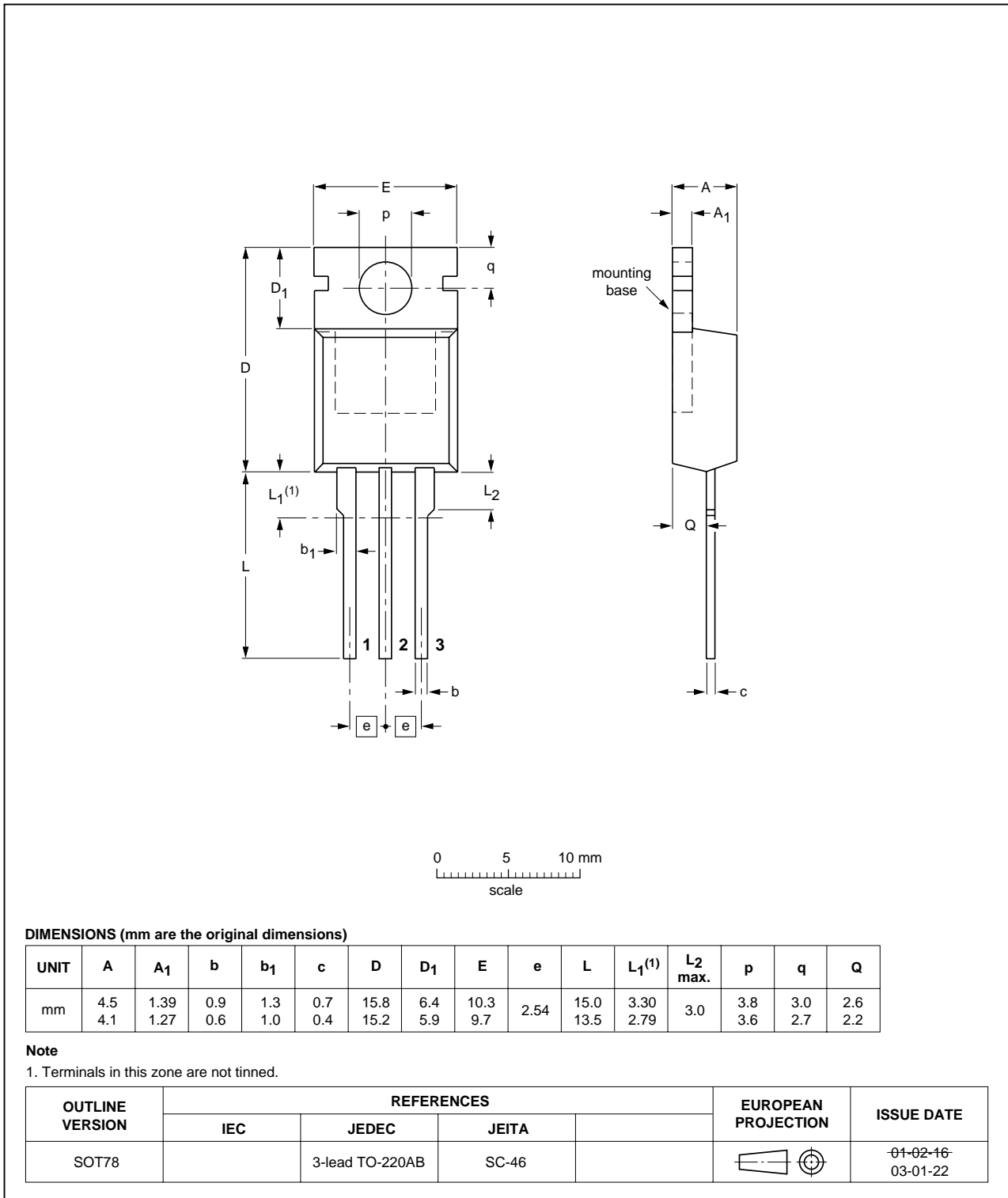


Fig 14. SOT78 (TO-220AB) package outline.

Plastic single-ended surface mounted package (D<sup>2</sup>-PAK); 3 leads (one lead cropped)

SOT404

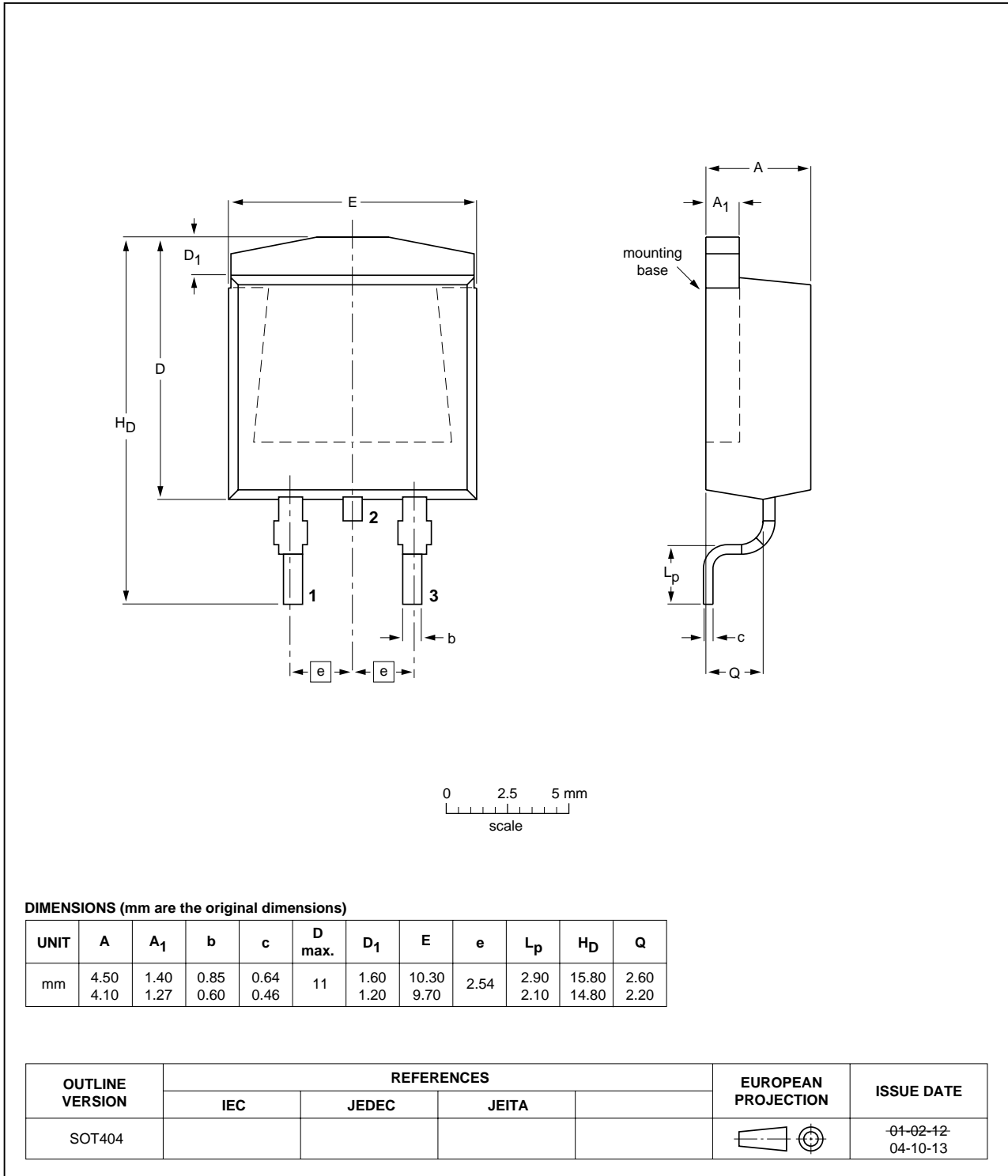


Fig 15. SOT404 (D<sup>2</sup>-PAK) package outline.



## 8. Revision history

Table 6: Revision history

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
PHP_PHB45NQ15T_1	20041108	Product data sheet	-	9397 750 14012	-

## 9. Data sheet status

Level	Data sheet status <sup>[1]</sup>	Product status <sup>[2] [3]</sup>	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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III	Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

[1] Please consult the most recently issued data sheet before initiating or completing a design.

[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

## 10. Definitions

**Short-form specification** — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

**Limiting values definition** — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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